Application/Control No.	Applicant(s)/Patent under Reexamination	
10/634,555	GAN ET AL.	
Examiner 1/2	Art Unit	
Kamran Afshar, 571-272-7796	2681	

SEARCHED					
Class	Subclass	Date	Examiner		
455	433	7/19/2005	КА		
455	432.3	7/19/2005	КА		
455	435.1	7/19/2005	КА		
455	445	7/19/2005	КА		
455	424	7/19/2005	KA		
455	560	7/19/2005	КА		
379	221.03	7/19/2005	KA		
379	221.01	7/19/2005	КА		
379	219	7/19/2005	KA		
707	201	7/20/2005	KA		
707	8 & 10	7/20/2005	KA		

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
	<u>.</u>				

	SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR			
East Search (US-PGPUB; USPAT; EPO; DERWENT; IBM_TDB)	7/19/2005	КА			
Joseph Feild	7/20/2005	КА			
Luke Wassum & William Trost	7/20/2005	КА			
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